

Basic EMC System 2.0

for measurements according to the basic standards of the EMC directive

Three phase version type EMV D 22500/APS:



The relating standards:

emission:

IEC/EN 61000-3-2

IEC/EN 61000-3-3 IEC/EN 61000-3-11

IEC/EN 61000-3-12

immunity:

IEC/EN 61000-4-4

IEC/EN 61000-4-5

IEC/EN 61000-4-7

IEC/EN 61000-4-7

IEC/EN 61000-4-11

IEC/EN 61000-4-13

IEC/EN 61000-4-14

IEC/EN 61000-4-17

IEC/EN 61000-4-27

IEC/EN 01000-4-21

IEC/EN 61000-4-28 IEC/EN 61000-4-29

IEC/EN 61000-4-23

IEC/EN 61000-4-34

IEC/EN 60146-1-1

IEC/EN 61000-2-2

IEC/EN 61131-2

IEC/EN 61496-1 IEC/EN 61800-3

IEC/EN 62040-2

SEMI F47-0706

The "Basic EMC System 2.0" is the fully compliant turnkey system for all line conducted Emission and Immunity tests according to the EMC directive.

It is available as a single phase and as a three-phase version.

The version number 2.0 relates to the original "Basic EMC system" released more than 25 years ago and since that time very successful in the market.

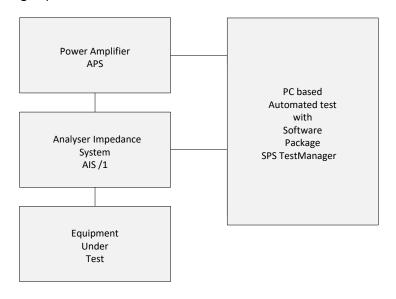
Above and beyond the standards the "Basic EMC System 2.0" is a universal grid simulation and measurement system for voltage, frequency and phase symmetry simulation.

On the other hand, the sources of the "Basic EMC System 2.0", the APS amplifiers are the new reference sources for many applications. Their improved technical performance and advantages (compared to the PAS sources) like low THD, very fast rise and fall time, stability and power capability are unique on the market.

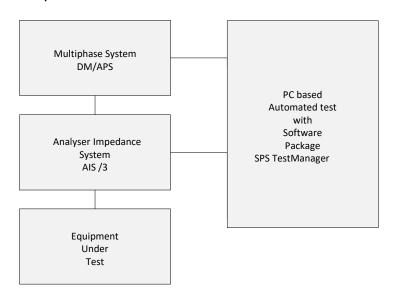


THE PRINCIPLE DIAGRAM:

Single phase version:



Three phase version:



The main components of the single-phase version of the "Basic EMC System 2.0":

- APS power amplifier with power supply NT www.spitzenberger.de/weblink/1107
- analyser reference system
 AIS
 including
 reference impedance
 harmonic analyser
 flickermeter
 http://www.spitzenberger.de/weblink/1303
- Software platform
 SPS TestManager

The main components of the three-phase version of the "Basic EMC System 2.0":

- 3x APS power amplifier with common power supply NT/D http://www.spitzenberger.de/weblink/1107
- analyser reference system

 AIS/3

 including

 reference impedance

 harmonic analyser

 flickermeter

 http://www.spitzenberger.de/weblink/1303
- Software platform
 SPS TestManager



Single phase version type EMV E 5000/APS:



"Basic EMC System 2.0" Single phase types:

- EMV E 1000/APS
- EMV E 2500/APS
- EMV E 5000/APS
- EMV E 7500/APS
- EMV E 10000/APS
- EMV E 15000/APS
- EMV E 20000/APS
- EMV E 25000/APS
- EMV E 30000/APS
- *EMV E 40000/APS*
- EMV E 50000/APS

"Basic EMC System 2.0" Three phase types:

- EMV D 3000/APS
- EMV D 7500/APS
- EMV D 15000/APS
- EMV D 22500/APS
- EMV D 30000/APS
- EMV D 45000/APS
- EMV D 60000/APS
- EMV D 75000/APS
- EMV D 90000/APS
- EMV D 120000/APS
- EMV D 150000/APS



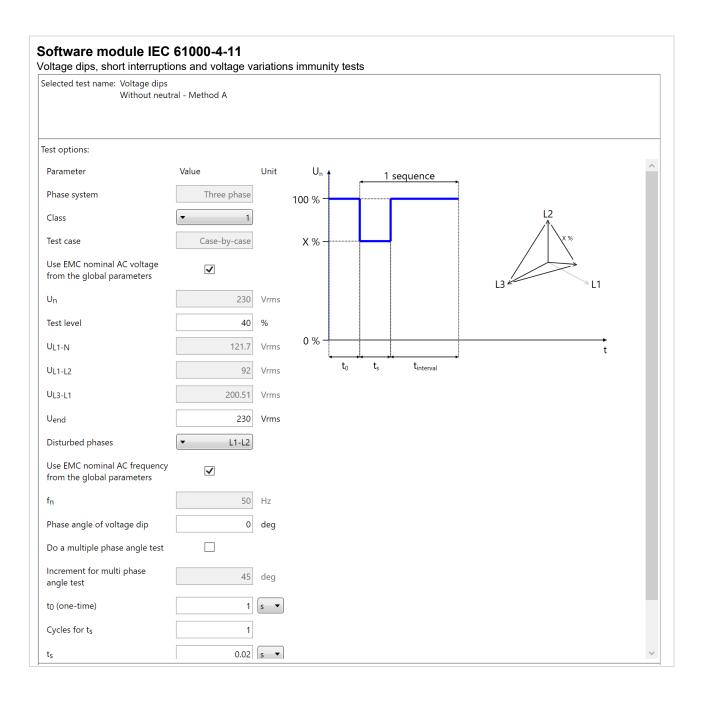
No. | Pinst, max | Pst | T_{max} [s] | d_{max} [%] | d_c [%]

Basic software unit SPS TESTMANAGER EMC - Framework for Basic EMC System software application File Options View Results Licence About Init devices Output on Output off Reset all devices **>** Test sequence 1 Current measurement mode L1 or L1/L2/L3 × Voltage range 230 Vrms G Ztest ▼ 200 ms Time window width Max. measured harmonics 40 Measuring period 2.5 min ▼ Source control -(g) - Z_{test} -(º)------v One phase Source phases 230 Vrms Test status Evaluation Current time: 00:00:00 [hh:mm:ss] / Total time: 00:02:30 [hh:mm:ss] Stop P Reset changes P Default ■ Stop Digital output Measurement ▶ Continue Software module IEC 61000-3-2/-3/-11/-12 - Automatic testing and measuring of harmonic emissions and flicker Selected test name: Harmonic measurement Test options: Current measurement mode ▼ L1 or L1/L2/L3 Voltage range 230 Vrms -G Z_{test} Current range Time window width ▼ 200 ms Max. measured harmon... Measuring period 2. Max. measured harmonics 40 2.5 min ▼ EUT Source control Source phases • One phase G Z_{test} 230 Vrms - 50 Hz Voltage Evaluation settings Selected test name: Flicker measurement (A) Device settings G RA JXA L1 ▼ 50 Hz Nominal frequency ▼ 230V 10 min ▼ Short time interval (T_{short}) Number of short time intervals (Nlong) 12 EUT 230 Vrms Nominal voltage G RA JXA dt threshold 3.3 % 240 mΩ Impedance RA 150 mΩ 160 mΩ 100 mΩ Impedance XN Test status Results No. | Pinst, max | Pst | T_{max} [s] | d_{max} [%] | d_c [%]











Software module IEC 61000-4-13

Harmonics and interharmonics including mains signalling at a.c. power port, low frequency immunity tests

Software module IEC 61000-4-14

Voltage fluctuation immunity test for equipment with input current not exceeding 16 A per phase

Software module IEC 61000-4-17

Ripple on d.c. input power port immunity test

Software module IEC 61000-4-27

Unbalance, immunity test for equipment with input current not exceeding 16 A per phase

Software module IEC 61000-4-28

Variation of power frequency, immunity test for equipment with input current not exceeding 16 A per phase

Software module IEC 61000-4-29

Voltage dips, short interruptions and voltage variations on d.c. input power port immunity tests

Software module IEC 61000-4-34

Voltage dips, short interruptions and voltage variations immunity tests for equipment with mains current more than 16 A per phase

Software module IEC 61000-4-4

Electrical fast transient/burst immunity test

Software module IEC 61000-4-5

Surge immunity test

Software module IEC 60146-1-1

Simulation of commutation notches

Software module IEC 61000-2-2

Compatibility levels for low-frequency conducted disturbances and signalling in public low-voltage power supply systems

Software module IEC 61131-2

Programmable controllers - Part 2: Equipment requirements and tests

Software module IEC 61496-1

Safety of machinery – voltage variation, frequency variation, harmonics, voltage interruptions

Software module IEC 61800-3

Adjustable speed electrical power drive systems

Software module IEC 62040-2

UPS immunity against harmonics, interharmonics, unbalance

Software module IEC TR 61547-1

Simulation of voltage fluctuations

Software module DNVGL-CG-0339 - Germanischer Lloyd

a.c. interference on d.c. mains and simulation of harmonics on a.c. mains

Software module SEMI F47-0706

Specification for semiconductor processing equipment voltage sag immunity



OPTIONS AND ADD-ONS FOR ALL SYSTEM VERSIONS:

- Pulse generator CE-tester for testing burst and surge pulses according to IEC/EN 61000-4-4 and IEC/EN 61000-4-5
- Inrush current option for IEC/EN 61000-4-11 to upgrade APS amplifiers < 30000VA to IEC required inrush current capability
- Magnetic field test option for IEC/EN 61000-4-8 magnetic field tests including various coil types for magnetic field generation
- Reference load for harmonics and flicker for testing and calibration
- Additional transformer units for higher rms voltages
- Programmable internal impedance of the APS amplifiers
- Additional operation mode 'Constant current' for APS amplifiers

OPTIONS AND ADD-ONS FOR THREE PHASE SYSTEM VERSIONS:

Common output for parallel operation
 Automated switching of single output terminals to common output terminals in parallel operation

